

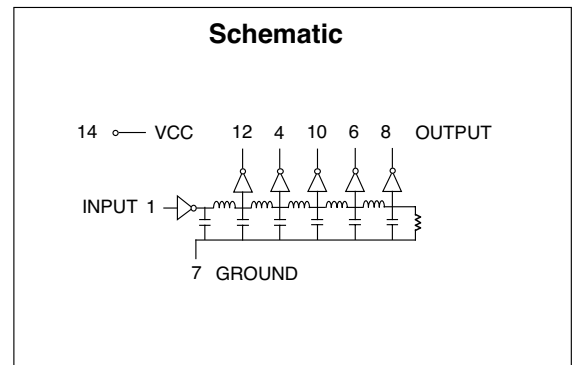
# 14 Pin DIP and SMD 5 Tap Both Edges Controlled Fast Logic TTL Compatible Active Delay Lines

Compatible with standard auto-insertable equipment and can be used in either infrared or vapor phase process.

Input to Tap $\pm 5\%$ or $\pm 2nS\ddagger$ Tap to Tap $\pm 7\%$ or $\pm 2nS\ddagger$ Tap		DIP Part Number	SMD Part Number	Input to Tap $\pm 5\%$ or $\pm 2nS\ddagger$ Tap to Tap $\pm 7\%$ or $\pm 2nS\ddagger$ Tap		DIP Part Number	SMD Part Number
5, 10, 15, 20	25	EPA3507-25	EPA3507G-25	40, 80, 120, 160	200	EPA3507-200	EPA3507G-200
6, 12, 18, 24	30	EPA3507-30	EPA3507G-30	45, 90, 135, 180	225	EPA3507-225	EPA3507G-225
7, 14, 21, 28	35	EPA3507-35	EPA3507G-35	50, 100, 150, 200	250	EPA3507-250	EPA3507G-250
8, 16, 24, 32	40	EPA3507-40	EPA3507G-40	60, 120, 180, 240	300	EPA3507-300	EPA3507G-300
9, 18, 27, 36	45	EPA3507-45	EPA3507G-45	70, 140, 210, 280	350	EPA3507-350	EPA3507G-350
10, 20, 30, 40	50	EPA3507-50	EPA3507G-50	80, 160, 240, 320	400	EPA3507-400	EPA3507G-400
12, 24, 36, 48	60	EPA3507-60	EPA3507G-60	84, 168, 252, 336	420	EPA3507-420	EPA3507G-420
15, 30, 45, 60	75	EPA3507-75	EPA3507G-75	88, 176, 264, 352	440	EPA3507-440	EPA3507G-440
20, 40, 60, 80	100	EPA3507-100	EPA3507G-100	90, 180, 270, 360	450	EPA3507-450	EPA3507G-450
25, 50, 75, 100	125	EPA3507-125	EPA3507G-125	84, 168, 252, 336	470	EPA3507-470	EPA3507G-470
30, 60, 90, 120	150	EPA3507-150	EPA3507G-150	100, 200, 300, 400	500	EPA3507-500	EPA3507G-500
35, 70, 105, 140	175	EPA3507-175	EPA3507G-175				

$\ddagger$  Whichever is greater. Delay measured @ 1.5V levels on leading and trailing edge w/ 15pF load on taps.  
Rise and Fall Time measured from 0.75 to 2.4V level.

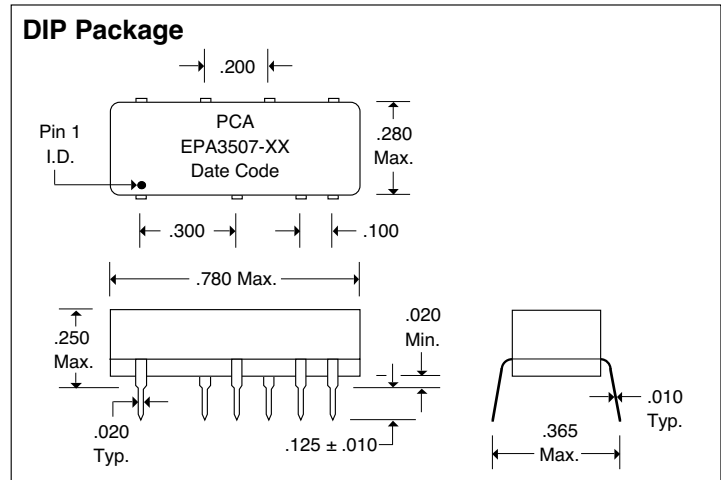
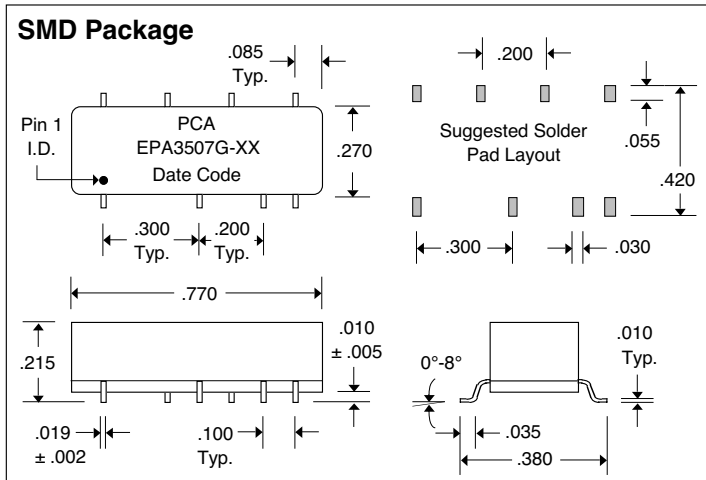
Electrical Characteristics				
Parameter	Test Conditions	Min.	Max.	Unit
$V_{OH}$	High-Level Output Voltage	$V_{CC} = \text{Min. } V_{IL} = \text{Max. } I_{OH} = \text{Max.}$	2.7	V
$V_{OL}$	Low-Level Output Voltage	$V_{CC} = \text{Min. } V_{IH} = \text{Min. } I_{OL} = \text{Max.}$	0.5	V
$V_{IK}$	Input Clamp Voltage	$V_{CC} = \text{Min. } I_I = I_{IK}$	-1.2	V
$I_{IH}$	High-Level Input Current	$V_{CC} = \text{Max. } V_{IN} = 2.7V$	20	$\mu A$
$I_{IL}$	Low-Level Input Current	$V_{CC} = \text{Max. } V_{IN} = 0.5V$	-0.6	mA
$I_{OS}$	Short Circuit Output Current	$V_{CC} = \text{Max. } V_{OUT} = 0.$ (One output at a time)	-60	mA
$I_{CCH}$	High-Level Supply Current	$V_{CC} = \text{Max. } V_{IN} = \text{OPEN}$	25	mA
$I_{CCL}$	Low-Level Supply Current	$V_{CC} = \text{Max. } V_{IN} = 0$	40	mA
$T_{RO}$	Output Rise Time	$T_d \leq 500 \text{ nS (0.75 to 2.4 Volts)}$ $T_d > 500 \text{ nS}$	4	nS
$N_H$	Fanout High-Level Output	$V_{CC} = \text{Max. } V_{OH} = 2.7V$	20 TTL LOAD	
$N_L$	Fanout Low-Level Output	$V_{CC} = \text{Max. } V_{OL} = 0.5V$	10 TTL LOAD	
$T_C$	Temp. Coeff. of Total Delay	$100 + (25000/TD) \text{ PPM}/^\circ C$		
$T_{STG}$	Storage Temp. Range	$-20^\circ C \text{ to } +100^\circ C$		



Recommended Operating Conditions				
Parameter	Test Conditions	Min.	Max.	Unit
$V_{CC}$	Supply Voltage	4.75	5.25	V
$V_{IH}$	High-Level Input Voltage	2.0		V
$V_{IL}$	Low-Level Input Voltage		0.8	V
$I_{IK}$	Input Clamp Current		-18	mA
$I_{OH}$	High-Level Output Current		-1.0	mA
$I_{OL}$	Low-Level Output Current		20	mA
$PW^*$	Input Pulse Width of Total Delay	40		%
$d^*$	Duty Cycle		50	%
$T_A$	Operating Free-Air Temperature	0	+70	$^\circ C$

\*These two values are inter-dependent.

Input Pulse Test Conditions @ 25° C			
Parameter	Test Conditions	Unit	Value
$E_{IN}$	Pulse Input Voltage	Volts	3.2
$P_W$	Pulse Width 1.2X Total Delay	nS	---
$T_{RI}$	Pulse Rise Time (10 - 90%)	nS	3.0
$P_{RR}$	Pulse Repetition Rate 4X $P_W$	MHz	---
$V_{CC}$	Supply Voltage	Volts	5.0



DSA3507G-XX & DSA3507-XX Rev. - 7/22/98

QAF-CSO1 Rev. B 8/25/94

Unless Otherwise Noted Dimensions in Inches  
Tolerances:  
Fractional =  $\pm 1/32$   
.XX =  $\pm .030$  .XXX =  $\pm .010$



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